

**Search Notes**

Application/Control No.

10/600,045

Examiner

German Colón

Applicant(s)/Patent under  
Reexamination

TAKAHASHI ET AL.

Art Unit

2879

**SEARCHED**

Class	Subclass	Date	Examiner
313	567-575 624-625 628,634 636,639	3/16/2005	GC
	489,11,17	3/17/2005	GC
	25,27,42		
	45-47		
	112,113		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR